

PTO-1449 REPRODUCED

ATTORNEY DOCKET NO.
2751.2001 US3

APPLICATION NO.
10/659,149

**INFORMATION DISCLOSURE CITATION
IN AN APPLICATION**

July 29, 2005

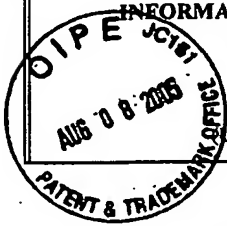
(Use several sheets if necessary)

APPLICANT
Christopher J. Nagel

FILING DATE
September 10, 2003

CONFIRMATION NO.
4820

**GROUP
1751**



U.S. PATENT DOCUMENTS

[illegible]

EXAMINER






DATE CONSIDERED


Mark

10/1/05

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PTO-1449 REPRODUCED INFORMATION DISCLOSURE CITATION IN AN APPLICATION July 29, 2005 (Use several sheets if necessary)	ATTORNEY DOCKET NO. 2751.2001 US3	APPLICATION NO. 10/659,149	
	APPLICANT Christopher J. Nagel		
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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)		
	AW3	Havrilla, George J., "X-Ray Fluorescence Spectrometry," Handbook of Instrumental Techniques for Analytical Chemistry, Frank A. Settle, Ed., Prentice-Hall, Inc.: pp. 459-468 (1997).
	AX3	DATABASE WPI, Section Ch, Week 197728, Derwent Publications Ltd., London, GB; XP002254970, Class M24, An 1977-49267Y and JP 52 065133 (Nippon Steel Corp), 30 May 1977 Abstract
	AY3	DATABASE WPI, Section PQ, Week 199438, Derwent Publications Ltd., London, GB; XP002254971, Class P53, AN 1994-308766 and KR 9 310 044 B (Lee D), 14 Oct 1993 Abstract
	AZ3	DATABASE WPI, Section Ch, Week 198204, Derwent Publications Ltd, London, GB; XP002254972, Class L03, AN 1982-06910E and JP 56 162427 A (Meidensha Elec Mgf Co Ltd), 14 Dec 1981 Abstract
	AR4	"A new Concept in XRF analysis" [On-Line], April 18, 2005, Retrieved from the Internet: http://www.Uniquant.com Website: (no date)

EXAMINER 	DATE CONSIDERED 10/1/05
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